250 MHz , General Purpose Voltage Feedback Op Amps

## AD8047/AD8048

| FEATURES |  |  |
| :--- | :--- | :--- |
| Wide Bandwidth | AD8047, G = +1 | AD8048, G = +2 |
| Small Signal | 250 MHz | 260 MHz |
| Large Signal (2 V p-p) | 130 MHz | 160 MHz |

5.8 mA Typical Supply Current

Low Distortion, (SFDR) Low Noise
-66 dBc typ @ 5 MHz
-54 dBc typ @ 20 MHz
$5.2 \mathrm{nV} / \sqrt{\mathrm{Hz}}$ (AD8047), $3.8 \mathrm{nV} / \sqrt{\mathrm{Hz}}$ (AD8048) Noise
Drives 50 pF Capacitive Load
High Speed
Slew Rate $750 \mathrm{~V} / \mu \mathrm{s}$ (AD8047), $1000 \mathrm{~V} / \mu \mathrm{s}$ (AD8048)
Settling 30 ns to $0.01 \%$, 2 V Step
$\pm 3$ V to $\pm 6$ V Supply Operation
APPLICATIONS
Low Power ADC Input Driver
Differential Amplifiers
IF/RF Amplifiers
Pulse Amplifiers
Professional Video
DAC Current to Voltage Conversion
Baseband and Video Communications
Pin Diode Receivers
Active Filters/Integrators

## PRODUCT DESCRIPTION

The AD8047 and AD8048 are very high speed and wide bandwidth amplifiers. The AD8047 is unity gain stable. The AD8048 is stable at gains of two or greater. The AD8047 and AD8048, which utilize a voltage feedback architecture, meet the requirements of many applications that previously depended on current feedback amplifiers.

A proprietary circuit has produced an amplifier that combines many of the best characteristics of both current feedback and voltage feedback amplifiers. For the power ( 6.6 mA max) the AD8047 and AD8048 exhibit fast and accurate pulse response ( 30 ns to $0.01 \%$ ) as well as extremely wide small signal and large signal bandwidth and low distortion. The AD8047 achieves -54 dBc distortion at 20 MHz and 250 MHz small signal and 130 MHz large signal bandwidths.

FUNCTIONAL BLOCK DIAGRAM
8-Pin Plastic Mini-DIP (N), Cerdip (Q) and SO (R) Packages


The AD8047 and AD8048's low distortion and cap load drive make the AD8047/AD8048 ideal for buffering high speed ADCs. They are suitable for 12 bit/ 10 MSPS or 8 bit/ 60 MSPS ADCs. Additionally, the balanced high impedance inputs of the voltage feedback architecture allow maximum flexibility when designing active filters.

The AD8047 and AD8048 are offered in industrial $\left(-40^{\circ} \mathrm{C}\right.$ to $+85^{\circ} \mathrm{C}$ ) temperature ranges and are available in 8-pin plastic DIP and SOIC packages.


Figure 1. AD8047 Large Signal Transient Response, $V_{O}=4 V p-p, G=+1$ otherwise under any patent or patent rights of Analog Devices.
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AD8047/AD8048-SPECIFICATIONS


| Parameter | Conditions | AD8047A |  |  | AD8048A |  |  | Units |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max |  |
| DYNAMIC PERFORMANCE |  |  |  |  |  |  |  |  |
| Bandwidth ( -3 dB ) |  |  |  |  |  |  |  |  |
| Small Signal | $\mathrm{V}_{\text {OUT }} \leq 0.4 \mathrm{~V}$ p-p | 170 | 250 |  | 180 | 260 |  | MHz |
| Large Signal ${ }^{1}$ | $\mathrm{V}_{\text {OUT }}=2 \mathrm{~V}$ p-p | 100 | 130 |  | 135 | 160 |  | MHz |
| Bandwidth for 0.1 dB Flatness | $\begin{aligned} & \mathrm{V}_{\text {OUT }}=300 \mathrm{mV} \text { p-p } \\ & 8047, \mathrm{R}_{\mathrm{F}}=0 \Omega ; 8048, \mathrm{R}_{\mathrm{F}}=200 \Omega \end{aligned}$ |  | 35 |  |  | 50 |  | $\mathrm{MHz}$ |
| Slew Rate, Average +/- | $\mathrm{V}_{\text {OUt }}=4 \mathrm{~V}$ Step | 475 | 750 |  | 740 | 1000 |  | V/ $/ \mathrm{s}$ |
| Rise/Fall Time | $\mathrm{V}_{\text {OUT }}=0.5 \mathrm{~V}$ Step |  | 1.1 |  |  | 1.2 |  | ns |
|  | $\mathrm{V}_{\text {OUT }}=4 \mathrm{~V}$ Step |  | 4.3 |  |  | 3.2 |  | ns |
| Settling Time |  |  |  |  |  |  |  |  |
| To 0.1\% | $\mathrm{V}_{\text {OUT }}=2 \mathrm{~V}$ Step |  | 13 |  |  | 13 |  | ns |
| To 0.01\% | $\mathrm{V}_{\text {OUT }}=2 \mathrm{~V}$ Step |  | 30 |  |  | 30 |  | ns |
| HARMONIC/NOISE PERFORMANCE |  |  |  |  |  |  |  |  |
| 2nd Harmonic Distortion | 2 V p-p; 20 MHz |  | -54 |  |  | -48 |  | dBc |
|  | $\mathrm{R}_{\mathrm{L}}=1 \mathrm{k} \Omega$ |  | -64 |  |  | -60 |  | dBc |
| 3rd Harmonic Distortion | 2 V p-p; 20 MHz |  | -60 |  |  | -56 |  | dBc |
|  | $\mathrm{R}_{\mathrm{L}}=1 \mathrm{k} \Omega$ |  | -61 |  |  | -65 |  | dBc |
| Input Voltage Noise | $\mathrm{f}=100 \mathrm{kHz}$ |  | 5.2 |  |  | 3.8 |  | $\mathrm{nV} / \sqrt{ } \overline{\mathrm{Hz}}$ |
|  | $\mathrm{f}=100 \mathrm{kHz}$ |  | 1.0 |  |  | 1.0 |  | $\mathrm{pA} / \sqrt{\mathrm{Hz}}$ |
| Average Equivalent Integrated |  |  |  |  |  |  |  |  |
| Input Noise Voltage | 0.1 MHz to 10 MHz |  | 16 |  |  | 11 |  | $\mu \mathrm{Vrms}$ |
| Differential Gain Error (3.58 MHz) | $\mathrm{R}_{\mathrm{L}}=150 \Omega, \mathrm{G}=+2$ |  | 0.02 |  |  | 0.01 |  |  |
| Differential Phase Error (3.58 MHz) | $\mathrm{R}_{\mathrm{L}}=150 \Omega, \mathrm{G}=+2$ |  | 0.03 |  |  | 0.02 |  | Degree |
| DC PERFORMANCE ${ }^{2}, \mathrm{R}_{\mathrm{L}}=150 \Omega$ |  |  |  |  |  |  |  |  |
|  | $\mathrm{T}_{\text {MIN }}-\mathrm{T}_{\text {MAX }}$ |  |  | 4 |  |  | 4 | mV |
| Offset Voltage Drift |  |  | $\pm 5$ |  |  | $\pm 5$ |  | $\mu \mathrm{V} /{ }^{\circ} \mathrm{C}$ |
| Input Bias Current |  |  |  |  |  |  | 3.5 | $\mu \mathrm{A}$ |
|  | $\mathrm{T}_{\mathrm{MIN}}-\mathrm{T}_{\mathrm{MAX}}$ |  |  | 6.5 |  |  | 6.5 | $\mu \mathrm{A}$ |
| Input Offset Current |  |  | 0.5 | 2 |  | 0.5 | 2 |  |
|  | $\mathrm{T}_{\mathrm{MIN}}-\mathrm{T}_{\mathrm{MAX}}$ |  |  | 3 |  |  | 3 | $\mu \mathrm{A}$ |
| Common-Mode Rejection Ratio | $\mathrm{V}_{\mathrm{CM}}= \pm 2.5 \mathrm{~V}$ | 74 | 80 |  | 74 | 80 |  | dB |
| Open-Loop Gain | $\mathrm{V}_{\text {OUT }}= \pm 2.5 \mathrm{~V}$ | $58$ | 62 |  | $65$ | 68 |  | $\mathrm{dB}$ |
|  | $\mathrm{T}_{\text {MIN }}-\mathrm{T}_{\mathrm{MAX}}$ |  |  |  |  |  |  |  |
| INPUT CHARACTERISTICS |  |  |  |  |  |  |  |  |
| Input Resistance |  |  | 500 |  |  | 500 |  | $\mathrm{k} \Omega$ |
| Input Capacitance |  |  | 1.5 |  |  | 1.5 |  | pF |
| Input Common-Mode Voltage Range |  |  | $\pm 3.4$ |  |  | $\pm 3.4$ |  | V |
| OUTPUT CHARACTERISTICS |  |  |  |  |  |  |  |  |
| Output Voltage Range, $\mathrm{R}_{\mathrm{L}}=150 \Omega$ |  | $\pm 2.8$ | $\pm 3.0$ |  | $\pm 2.8$ | $\pm 3.0$ |  | V |
| Output Current |  |  | 50 |  |  | 50 |  | mA |
| Output Resistance |  |  | 0.2 |  |  | 0.2 |  | $\Omega$ |
| Short Circuit Current |  |  | 130 |  |  | 130 |  | mA |
| POWER SUPPLY |  |  |  |  |  |  |  |  |
| Operating Range |  | $\pm 3.0$ |  | $\pm 6.0$ | $\pm 3.0$ |  | $\pm 6.0$ | V |
| Quiescent Current |  |  |  |  |  |  | 6.6 | mA |
|  | $\mathrm{T}_{\text {MIN }}-\mathrm{T}_{\text {MAX }}$ |  |  | 7.5 |  |  | 7.5 | mA |
| Power Supply Rejection Ratio |  | 72 | 78 |  | 72 | 78 |  | dB |

[^0]ABSOLUTE MAXIMUM RATINGS ${ }^{1}$
Supply Voltage ..... 12.6 V
Voltage Swing $\times$ Bandwidth Product (AD8047)(AD8048) . . . $250 \mathrm{~V}-\mathrm{MHz}$
Internal Power Dissipation ${ }^{2}$
Plastic Package (N)

$\qquad$ ..... 1.3 Watts
Small Outline Package (R) ..... 0.9 Watts
Input Voltage (Common Mode) ..... $\pm \mathrm{V}_{\mathrm{S}}$
Differential Input Voltage ..... $\pm 1.2 \mathrm{~V}$
Output Short Circuit Duration
Observe Power Derating Curves
Storage Temperature Range (N, R) . . . . . . . $-65^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$
Operating Temperature Range (A Grade) ... $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
Lead Temperature Range (Soldering 10 sec ) ..... $+300^{\circ} \mathrm{C}$

## NOTES

${ }^{1}$ Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
${ }^{2}$ Specification is for device in free air:
8 -Pin Plastic DIP Package: $\theta_{\mathrm{JA}}=90^{\circ} \mathrm{C} / \mathrm{Watt}$ 8 -Pin SOIC Package: $\theta_{\mathrm{JA}}=140^{\circ} \mathrm{C} / \mathrm{W}$ att

## METALIZATION PHOTOS

Dimensions shown in inches and (mm).
Connect Substrate to $-V_{S}$.


## MAXIMUM POWER DISSIPATION

The maximum power that can be safely dissipated by these devices is limited by the associated rise in junction temperature. The maximum safe junction temperature for plastic encapsulated devices is determined by the glass transition temperature of the plastic, approximately $+150^{\circ} \mathrm{C}$. Exceeding this limit temporarily may cause a shift in parametric performance due to a change in the stresses exerted on the die by the package. Exceeding a junction temperature of $+175^{\circ} \mathrm{C}$ for an extended period can result in device failure.
While the AD8047 and AD8048 are internally short circuit protected, this may not be sufficient to guarantee that the maximum junction temperature $\left(+150^{\circ} \mathrm{C}\right)$ is not exceeded under all conditions. To ensure proper operation, it is necessary to observe the maximum power derating curves.


Figure 2. Plot of Maximum Power Dissipation vs. Temperature

ORDERING GUIDE

| Model | Temperature <br> Range | Package <br> Description | Package <br> Option |
| :--- | :--- | :--- | :--- |
| AD8047AN | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | Plastic DIP | $\mathrm{N}-8$ |
| AD8047AR | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SOIC <br> Evaluation <br> AD8047-EB | $\mathrm{R}-8$ |
| AD8048AN | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | Board <br> Plastic DIP | $\mathrm{N}-8$ |
| AD8048AR | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | SOIC <br> AD8048-EB | Evaluation <br> Board |

*N = Plastic DIP; R= SOIC (Small Outline Integrated Circuit)

## CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although these devices feature proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

## AD8047-Typical Characteristics



Figure 3. Noninverting Configuration, $G=+1$


Figure 4. Large Signal Transient Response; $V_{O}=4 V p-p, G=+1$


Figure 5. Small Signal Transient Response; $V_{O}=400 m V p-p, G=+1$


Figure 6. Inverting Configuration, $G=-1$


Figure 7. Large Signal Transient Response; $V_{O}=4 V p-p, G=-1, R_{F}=R_{I N}=200 \Omega$


Figure 8. Small Signal Transient Response; $V_{O}=400 \mathrm{mV} p-p, G=-1, R_{F}=R_{I N}=200 \Omega$

## AD8048-Typical Characteristics



Figure 9. Noninverting Configuration, $G=+2$


Figure 10. Large Signal Transient Response;
$V_{O}=4 V p-p, G=+2, R_{F}=R_{I N}=200 \Omega$


Figure 11. Small Signal Transient Response; $V_{O}=400 \mathrm{mV} p-p, G=+2, R_{F}=R_{I N}=200 \Omega$


Figure 12. Inverting Configuration, $G=-1$


Figure 13. Large Signal Transient Response; $V_{O}=4 V p-p, G=-1, R_{F}=R_{I N}=200 \Omega$


Figure 14. Small Signal Transient Response; $V_{O}=400 \mathrm{mV} p-p, G=-1, R_{F}=R_{I N}=200 \Omega$

## AD8047-Typical Characteristics



Figure 15. AD8047 Small Signal Frequency Response $G=+1$


Figure 16. AD8047 0.1 dB Flatness, $G=+1$


Figure 17. AD8047 Open-Loop Gain and Phase Margin vs. Frequency


Figure 18. AD8047 Large Signal Frequency Response, $G=+1$


Figure 19. AD8047 Small Signal Frequency Response, $G=-1$


Figure 20. AD8047 Harmonic Distortion vs. Frequency, $G=+1$


Figure 21. AD8047 Harmonic Distortion vs. Frequency, $G=+1$


Figure 22. AD8047 Harmonic Distortion vs. Output Swing, $G=+1$


Figure 23. AD8047 Differential Gain and Phase Error, $G=+2, R_{L}=150 \Omega, R_{F}=200 \Omega, R_{I N}=200 \Omega$


Figure 24. AD8047 Short-Term Settling Time, $G=+1$


Figure 25. AD8047 Long-Term Settling Time, $G=+1$


Figure 26. AD8047 Noise vs. Frequency

## AD8048-Typical Characteristics



Figure 27. AD8048 Small Signal Frequency Response, $G=+2$


Figure 28. AD8048 0.1 dB Flatness, $G=+2$


Figure 29. AD8048 Open-Loop Gain and Phase Margin vs. Frequency


Figure 30. AD8048 Large Signal Frequency Response, $G=+2$


Figure 31. AD8048 Small Signal Frequency Response, $G=-1$


Figure 32. AD8048 Harmonic Distortion vs. Frequency, $G=+2$


Figure 33. AD8048 Harmonic Distortion vs. Frequency, $G=+2$


Figure 34. AD8048 Harmonic Distortion vs. Output Swing, $G=+2$


Figure 35. AD8048 Differential Gain and Phase Error, $G=+2, R_{L}=150 \Omega, R_{F}=200 \Omega, R_{I N}=200 \Omega$


Figure 36. AD8048 Short-Term Settling Time, $G=+2$


Figure 37. AD8048 Long-Term Settling Time 2 V Step, $G=+2$


Figure 38. AD8048 Noise vs. Frequency

## AD8047/AD8048-Typical Characteristics



Figure 39. AD8047 CMRR vs. Frequency


Figure 40. AD8047 Output Resistance vs. Frequency, $G=+1$


Figure 41. AD8047 PSRR vs. Frequency


Figure 42. AD8048 CMRR vs. Frequency


Figure 43. AD8048 Output Resistance vs. Frequency, $G=+2$


Figure 44. AD8048 PSRR vs. Frequency, $G=+2$


Figure 45. AD8047/AD8048 Output Swing vs. Temperature


Figure 46. AD8047/AD8048 Open-Loop Gain vs. Temperature


Figure 47. AD8047/AD8048 PSRR vs. Temperature


Figure 48. AD8047/AD8048 CMRR vs. Temperature


Figure 49. AD8047/AD8048 Supply Current vs. Temperature


Figure 50. AD8047/AD8048 Input Offset Voltage vs. Temperature

## AD8047/AD8048

## THEORY OF OPERATION

## General

The AD8047 and AD8048 are wide bandwidth, voltage feedback amplifiers. Since their open-loop frequency response follows the conventional 6 dB /octave roll-off, their gain bandwidth product is basically constant. Increasing their closed-loop gain results in a corresponding decrease in small signal bandwidth. This can be observed by noting the bandwidth specification between the AD8047 (gain of 1) and AD8048 (gain of 2).

## Feedback Resistor Choice

The value of the feedback resistor is critical for optimum performance on the AD8047 and AD8048. For maximum flatness at a gain of $2, \mathrm{R}_{\mathrm{F}}$ and $\mathrm{R}_{\mathrm{G}}$ should be set to $200 \Omega$ for the AD 8048 . When the AD8047 is configured as a unity gain follower, $\mathrm{R}_{\mathrm{F}}$ should be set to $0 \Omega$ (no feedback resistor should be used) for the plastic DIP and $66.5 \Omega$ for the SOIC.


Figure 51. Noninverting Operation


Figure 52. Inverting Operation
When the AD8047 is used in the transimpedance (I to V) mode, such as in photodiode detection, the value of $\mathrm{R}_{\mathrm{F}}$ and diode capacitance $\left(\mathrm{C}_{\mathrm{I}}\right)$ are usually known. Generally, the value of $\mathrm{R}_{\mathrm{F}}$ selected will be in the $\mathrm{k} \Omega$ range, and a shunt capacitor $\left(\mathrm{C}_{\mathrm{F}}\right)$ across $R_{F}$ will be required to maintain good amplifier stability. The value of $\mathrm{C}_{\mathrm{F}}$ required to maintain optimal flatness ( $<1 \mathrm{~dB}$ Peaking) and settling time can be estimated as:

$$
C_{F} \cong\left[\left(2 \omega_{O} C_{I} R_{F}-1\right) / \omega_{O}^{2} R_{F}^{2}\right]^{1 / 2}
$$

where $\omega_{\mathrm{O}}$ is equal to the unity gain bandwidth product of the amplifier in rad/sec, and $C_{I}$ is the equivalent total input capacitance at the inverting input. Typically $\omega_{\mathrm{O}}=800 \times 10^{6}$ $\mathrm{rad} / \mathrm{sec}$ (see Open-Loop Frequency Response curve, Figure 17).
As an example, choosing $R_{F}=10 \mathrm{k} \Omega$ and $\mathrm{C}_{\mathrm{I}}=5 \mathrm{pF}$, requires $\mathrm{C}_{\mathrm{F}}$ to be 1.1 pF (Note: $\mathrm{C}_{\mathrm{I}}$ includes both source and parasitic circuit capacitance). The bandwidth of the amplifier can be estimated using the $\mathrm{C}_{\mathrm{F}}$ calculated as:

$$
f_{3 d B} \cong \frac{1.6}{2 \pi R_{F} C_{F}}
$$

For general voltage gain applications, the amplifier bandwidth can be closely estimated as:

$$
f_{3 d B} \cong \frac{\omega_{O}}{2 \pi\left[1+\left(\frac{R_{F}}{R_{G}}\right)\right]}
$$

This estimation loses accuracy for gains of $+2 /-1$ or lower due to the amplifier's damping factor. For these "low gain" cases, the bandwidth will actually extend beyond the calculated value (see Closed-Loop BW plots, Figures 15 and 26).
As a rule of thumb, capacitor $\mathrm{C}_{\mathrm{F}}$ will not be required if:

$$
\left(R_{F} \| R_{G}\right) \times C_{I} \leq \frac{N G}{4 \omega_{O}}
$$

where $N G$ is the Noise Gain $\left(1+\mathrm{R}_{\mathrm{F}} / \mathrm{R}_{\mathrm{G}}\right)$ of the circuit. For most voltage gain applications, this should be the case.


Figure 53. Transimpedance Configuration

## Pulse Response

Unlike a traditional voltage feedback amplifier, where the slew speed is dictated by its front end dc quiescent current and gain bandwidth product, the AD8047 and AD8048 provide "on demand" current that increases proportionally to the input "step" signal amplitude. This results in slew rates ( $1000 \mathrm{~V} / \mu \mathrm{s}$ ) comparable to wideband current feedback designs. This, combined with relatively low input noise current ( $1.0 \mathrm{pA} / \sqrt{\mathrm{Hz}}$ ), gives the AD8047 and AD8048 the best attributes of both voltage and current feedback amplifiers.

## Large Signal Performance

The outstanding large signal operation of the AD8047 and AD 8048 is due to a unique, proprietary design architecture. In order to maintain this level of performance, the maximum $180 \mathrm{~V}-\mathrm{MHz}$ product must be observed, (e.g., @ 100 MHz , $\mathrm{V}_{\mathrm{O}} \leq 1.8 \mathrm{~V}$ p-p) on the AD8047 and $250 \mathrm{~V}-\mathrm{MHz}$ product on the AD8048.

## Power Supply Bypassing

Adequate power supply bypassing can be critical when optimizing the performance of a high frequency circuit. Inductance in the power supply leads can form resonant circuits that produce peaking in the amplifier's response. In addition, if large current transients must be delivered to the load, then bypass capacitors (typically greater than $1 \mu \mathrm{~F}$ ) will be required to provide the best settling time and lowest distortion. A parallel combination of at least $4.7 \mu \mathrm{~F}$, and between $0.1 \mu \mathrm{~F}$ and $0.01 \mu \mathrm{~F}$, is recommended. Some brands of electrolytic capacitors will require a small series damping resistor $\approx 4.7 \Omega$ for optimum results.

## Driving Capacitive Loads

The AD8047/AD8048 have excellent cap load drive capability for high speed op amps as shown in Figures 55 and 57. However, when driving cap loads greater than 25 pF , the best frequency response is obtained by the addition of a small series resistance. It is worth noting that the frequency response of the
circuit when driving large capacitive loads will be dominated by the passive roll-off of $\mathrm{R}_{\text {SERIES }}$ and $\mathrm{C}_{\mathrm{L}}$.


Figure 54. Driving Capacitive Loads


Figure 55. AD8047 Large Signal Transient Response; $V_{O}=2 V p-p, G=+1, R_{F}=0 \Omega, R_{\text {SERIES }}=0 \Omega, C_{L}=27 p F$


Figure 56. Driving Capacitive Loads


Figure 57. AD8048 Large Signal Transient Response; $V_{O}=2 \mathrm{Vp}-\mathrm{p}, \mathrm{G}=+2, R_{F}=R_{I N}=200 \Omega, R_{\text {SERIES }}=0 \Omega$, $C_{L}=27 \mathrm{pF}$

## APPLICATIONS

The AD8047 and AD8048 are voltage feedback amplifiers well suited for such applications as photodetectors, active filters, and $\log$ amplifiers. The devices' wide bandwidth ( 260 MHz ), phase margin $\left(65^{\circ}\right)$, low noise current ( $1.0 \mathrm{pA} / \sqrt{\mathrm{Hz}}$ ), and slew rate
( $1000 \mathrm{~V} / \mu \mathrm{s}$ ) give higher performance capabilities to these applications over previous voltage feedback designs.
With a settling time of 30 ns to $0.01 \%$ and 13 ns to $0.1 \%$, the devices are an excellent choice for DAC I/V conversion. The same characteristics along with low harmonic distortion make them a good choice for ADC buffering/amplification. With superb linearity at relatively high signal frequencies, the AD8047 and AD8048 are ideal drivers for ADCs up to 12 bits.

## Operation as a Video Line Driver

The AD8047 and AD8048 have been designed to offer outstanding performance as video line drivers. The important specifications of differential gain ( $0.01 \%$ ) and differential phase $\left(0.02^{\circ}\right)$ meet the most exacting HDTV demands for driving video loads.


Figure 58. Video Line Driver

## Active Filters

The wide bandwidth and low distortion of the AD8047 and AD8048 are ideal for the realization of higher bandwidth active filters. These characteristics, while being more common in many current feedback op amps, are offered in the AD8047 and AD8048 in a voltage feedback configuration. Many active filter configurations are not realizable with current feedback amplifiers.
A multiple feedback active filter requires a voltage feedback amplifier and is more demanding of op amp performance than other active filter configurations such as the Sallen-Key. In general, the amplifier should have a bandwidth that is at least ten times the bandwidth of the filter if problems due to phase shift of the amplifier are to be avoided.
Figure 59 is an example of a 20 MHz low pass multiple feedback active filter using an AD8048.


Figure 59. Active Filter Circuit
Choose:
$F_{O}=$ Cutoff Frequency $=20 \mathrm{MHz}$
$\alpha=$ Damping Ratio $=1 / \mathrm{Q}=2$

## AD8047/AD8048

$\mathrm{H}=$ Absolute Value of Circuit Gain $=\left|\frac{-R 4}{R 1}\right|=1$ Then:

$$
\begin{aligned}
& k=2 \pi F_{O} C 1 \\
& C 2=\frac{4 C 1(H+1)}{\alpha^{2}} \\
& R 1=\frac{\alpha}{2 H K} \\
& R 3=\frac{\alpha}{2 K(H+1)} \\
& R 4=H(R 1)
\end{aligned}
$$

## A/D Converter Driver

As A/D converters move toward higher speeds with higher resolutions, there becomes a need for high performance drivers that will not degrade the analog signal to the converter. It is desirable from a system's standpoint that the $\mathrm{A} / \mathrm{D}$ be the element in the signal chain that ultimately limits overall distortion. This places new demands on the amplifiers used to drive fast, high resolution A/Ds.

With high bandwidth, low distortion and fast settling time the AD8047 and AD8048 make high performance A/D drivers for advanced converters. Figure 60 is an example of an AD8047 used as an input driver for an AD872, a 12-bit, 10 MSPS A/D converter.

## Layout Considerations

The specified high speed performance of the AD8047 and AD8048 requires careful attention to board layout and component selection. Proper RF design techniques and low pass parasitic component selection are mandatory

The PCB should have a ground plane covering all unused portions of the component side of the board to provide a low impedance path. The ground plane should be removed from the area near the input pins to reduce stray capacitance.
Chip capacitors should be used for the supply bypassing (see Figure 60). One end should be connected to the ground plane and the other within $1 / 8$ inch of each power pin. An additional large ( $0.47 \mu \mathrm{~F}-10 \mu \mathrm{~F}$ ) tantalum electrolytic capacitor should be connected in parallel, though not necessarily so close, to supply current for fast, large signal changes at the output.
The feedback resistor should be located close to the inverting input pin in order to keep the stray capacitance at this node to a minimum. Capacitance variations of less than 1 pF at the inverting input will significantly affect high speed performance.
Stripline design techniques should be used for long signal traces (greater than about 1 inch). These should be designed with a characteristic impedance of $50 \Omega$ or $75 \Omega$ and be properly terminated at each end.

## Evaluation Board

An evaluation board for both the AD8047 and AD8048 is available that has been carefully laid out and tested to demonstrate that the specified high speed performance of the device can be realized. For ordering information, please refer to the Ordering Guide.
The layout of the evaluation board can be used as shown or serve as a guide for a board layout.


Figure 60. AD8047 Used as Driver for an AD872, a 12-Bit, 10 MSPS A/D Converter


Noninverting Configuration


Supply Bypassing

Figure 61. Noninverting Configurations for Evaluation Boards

Table I.

|  | AD8047 |  |  |  |  |  |  |  |  |  |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :---: |
| Component | $\mathbf{- 1}$ | $\mathbf{+ 1}$ | $\mathbf{+ 2}$ | $\mathbf{+ 1 0}$ | $\mathbf{+ 1 0 1}$ | $\mathbf{- 1}$ | $\mathbf{+ 2}$ | $\mathbf{+ 1 0}$ | $\mathbf{+ 1 0 1}$ |  |
| $\mathrm{R}_{\mathrm{F}}$ | $200 \Omega$ | $66.5 \Omega$ | $1 \mathrm{k} \Omega$ | $1 \mathrm{k} \Omega$ | $1 \mathrm{k} \Omega$ | $200 \Omega$ | $200 \Omega$ | $1 \mathrm{k} \Omega$ | $1 \mathrm{k} \Omega$ |  |
| $\mathrm{R}_{\mathrm{G}}$ | $200 \Omega$ | - | $1 \mathrm{k} \Omega$ | $110 \Omega$ | $10 \Omega$ | $200 \Omega$ | $200 \Omega$ | $110 \Omega$ | $10 \Omega$ |  |
| $\mathrm{R}_{\mathrm{O}}$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ |  |
| $\mathrm{R}_{\mathrm{S}}$ | - | $0 \Omega$ | $0 \Omega$ | $0 \Omega$ | $0 \Omega$ | - | $0 \Omega$ | $0 \Omega$ | $0 \Omega$ |  |
| $\mathrm{R}_{\mathrm{T}}$ | $66.5 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $66.5 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ | $49.9 \Omega$ |  |
| Small Signal |  |  |  |  |  |  |  |  |  |  |
| $\mathrm{BW}(-3 \mathrm{~dB})$ | 90 MHz | 260 MHz | 95 MHz | 10 MHz | 1 MHz | 250 MHz | 250 MHz | 22 MHz | 2 MHz |  |



Figure 62. Evaluation Board Silkscreen (Top)


Figure 63. Board Layout (Solder Side)


Figure 64. Board Layout (Component Side)

## OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

8-Pin Plastic DIP
(N Package)


8-Pin Plastic SOIC
(R Package)


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[^0]:    NOTES
    ${ }^{1}$ See Max Ratings and Theory of Operation sections of data sheet.
    ${ }^{2}$ Measured at $\mathrm{A}_{\mathrm{V}}=50$.
    ${ }^{3}$ Measured with respect to the inverting input.
    Specifications subject to change without notice.

